

**Search Notes**

Application/Control No.

09/850,114

Examiner

Djenane M. Bayard

Applicant(s)/Patent under  
Reexamination

TAKENAGA, TAKASHI

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	206	8/17/2005	DB
709	218	8/17/2005	DB
345	619	8/17/2005	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
709	206	8/17/2005	DB
709	218	8/17/2005	DB
345	619	8/17/2005	DB

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/17/2005	DB
NPL (google, IEEE, safari online book)	8/17/2005	DB
Consulted with M. Meky	8/17/2005	DB
Stic Search (Npl and Patent Literature)	8/8/2005	DB
Inventor's search	8/19/2005	